

# AOT20N25

# 250V,20A N-Channel MOSFET

# **General Description**

The AOT20N25 is fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications.By providing low  $R_{DS(on)}$ ,  $C_{iss}$  and  $C_{rss}$  along with guaranteed avalanche capability this device can be adopted quickly into new and existing offline power supply designs. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

For Halogen Free add "L" suffix to part number: AOT20N25L

# **Product Summary**

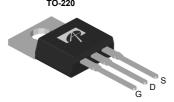
 $\rm V_{\rm DS}$ 300V@150℃ I<sub>D</sub> (at V<sub>GS</sub>=10V) 20A  $R_{DS(ON)}$  (at  $V_{GS}$ =10V) < 0.17Ω

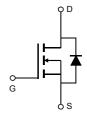
100% UIS Tested 100% R<sub>q</sub> Tested



Top View







| Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted         |                       |                                   |            |       |  |  |  |  |
|--|-----------------------|-----------------------------------|------------|-------|--|--|--|--|
| Parameter  |                       | Symbol                            | AOT20N25   | Units |  |  |  |  |
| Drain-Source Voltage   |                       | V <sub>DS</sub>                   | 250        | V     |  |  |  |  |
| Gate-Source Voltage  |                       | V <sub>GS</sub>                   | ±30        | V     |  |  |  |  |
| Continuous Drain<br>Current  | T <sub>C</sub> =25°C  | I-                                | 20         |       |  |  |  |  |
|  | T <sub>C</sub> =100°C | I <sub>D</sub>                    | 14         | A     |  |  |  |  |
| Pulsed Drain Current C   |                       | I <sub>DM</sub>                   | 51         |       |  |  |  |  |
| Avalanche Current <sup>C</sup>   |                       | I <sub>AS</sub>                   | 4.5        | A     |  |  |  |  |
| Single pulsed avalanche energy <sup>G</sup>                                  |                       | E <sub>AS</sub>                   | 608        | mJ    |  |  |  |  |
| Peak diode recovery dv/dt  |                       | dv/dt                             | 5          | V/ns  |  |  |  |  |
|  | T <sub>C</sub> =25°C  | P <sub>D</sub>                    | 208        | W     |  |  |  |  |
| Power Dissipation <sup>B</sup>   | Derate above 25°C     | FD                                | 1.7        | W/ °C |  |  |  |  |
| Junction and Storage Temperature Range                                       |                       | T <sub>J</sub> , T <sub>STG</sub> | -55 to 150 | °C    |  |  |  |  |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds |                       | TL                                | 300        | °C    |  |  |  |  |
| Thermal Characteris  |                       |                                   |            | II.   |  |  |  |  |
| Parameter  |                       | Symbol                            | AOT20N25   | Units |  |  |  |  |
| Maximum Junction-to-Ambient A,D  |                       | $R_{\theta JA}$                   | 65         | °C/W  |  |  |  |  |
| Maximum Case-to-sink <sup>A</sup>  |                       | R <sub>θCS</sub>                  | 0.5        | °C/W  |  |  |  |  |
| Maximum Junction-to-Case   |                       | R <sub>θJC</sub>                  | 0.6        | °C/W  |  |  |  |  |



#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                    | Parameter                             | Conditions  | Min | Тур  | Max  | Units |  |  |  |
|---------------------------|---------------------------------------|---|-----|------|------|-------|--|--|--|
| STATIC PARAMETERS         |                                       |   |     |      |      |       |  |  |  |
| BV <sub>DSS</sub>         | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C  | 250 |      |      |       |  |  |  |
|                           |                                       | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C |     | 300  |      | V     |  |  |  |
| BV <sub>DSS</sub><br>/ΔTJ | Zero Gate Voltage Drain Current       | ID=250µA, VGS=0V  |     | 0.25 |      | V/°C  |  |  |  |
|                           | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =250V, V <sub>GS</sub> =0V                        |     |      | 1    |       |  |  |  |
|                           |                                       | V <sub>DS</sub> =200V, T <sub>J</sub> =125°C                      |     |      | 10   | μΑ    |  |  |  |
| $I_{GSS}$                 | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±30V                        |     |      | ±100 | nA    |  |  |  |
| $V_{GS(th)}$              | Gate Threshold Voltage                | $V_{DS}$ =5V, $I_{D}$ =250 $\mu$ A                                | 3.2 | 3.8  | 4.5  | V     |  |  |  |
| R <sub>DS(ON)</sub>       | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =10A                         |     | 0.14 | 0.17 | Ω     |  |  |  |
| <b>g</b> FS               | Forward Transconductance              | V <sub>DS</sub> =40V, I <sub>D</sub> =10A                         |     | 16   |      | S     |  |  |  |
| $V_{SD}$                  | Diode Forward Voltage                 | I <sub>S</sub> =1A,V <sub>GS</sub> =0V                            |     | 0.72 | 1    | V     |  |  |  |
| I <sub>S</sub>            | Maximum Body-Diode Continuous Current |   |     |      | 20   | Α     |  |  |  |
| I <sub>SM</sub>           | Maximum Body-Diode Pulsed Current     |   |     |      | 51   | Α     |  |  |  |
| DYNAMIC                   | PARAMETERS                            |   |     |      |      |       |  |  |  |
| C <sub>iss</sub>          | Input Capacitance                     |   |     | 1028 |      | pF    |  |  |  |
| C <sub>oss</sub>          | Output Capacitance                    | $V_{GS}$ =0V, $V_{DS}$ =25V, f=1MHz                               |     | 167  |      | pF    |  |  |  |
| C <sub>rss</sub>          | Reverse Transfer Capacitance          |   |     | 11   |      | pF    |  |  |  |
| $R_g$                     | Gate resistance                       | $V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz                                | 1.9 | 3.9  | 5.9  | Ω     |  |  |  |
| SWITCHING PARAMETERS      |                                       |   |     |      |      |       |  |  |  |
| $Q_g$                     | Total Gate Charge                     |   |     | 20   | 25   | nC    |  |  |  |
| $Q_{gs}$                  | Gate Source Charge                    | $V_{GS}$ =10V, $V_{DS}$ =200V, $I_{D}$ =20A                       |     | 5.7  |      | nC    |  |  |  |
| $Q_{gd}$                  | Gate Drain Charge                     |   |     | 8    |      | nC    |  |  |  |
| $t_{D(on)}$               | Turn-On DelayTime                     |   |     | 27   |      | ns    |  |  |  |
| t <sub>r</sub>            | Turn-On Rise Time                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =125V, I <sub>D</sub> =20A, |     | 31   |      | ns    |  |  |  |
| $t_{D(off)}$              | Turn-Off DelayTime                    | $R_G=25\Omega$  |     | 70   |      | ns    |  |  |  |
| t <sub>f</sub>            | Turn-Off Fall Time                    |   |     | 25   |      | ns    |  |  |  |
| t <sub>rr</sub>           | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A,dI/dt=100A/μs,V <sub>DS</sub> =100V           |     | 179  |      | ns    |  |  |  |
| Q <sub>rr</sub>           | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A,dI/dt=100A/μs,V <sub>DS</sub> =100V           |     | 1.6  |      | μС    |  |  |  |

A. The value of R  $_{\rm \theta JA}$  is measured with the device in a still air environment with T  $_{\rm A}$  =25  $^{\circ}$  C.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C, Ratings are based on low frequency and duty cycles to keep initial T<sub>1</sub>=25° C.

D. The R  $_{\theta JA}$  is the sum of the thermal impedance from junction to case R  $_{\theta JC}$  and case to ambient.

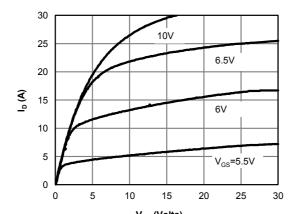
E. The static characteristics in Figures 1 to 6 are obtained using <300  $\mu s$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

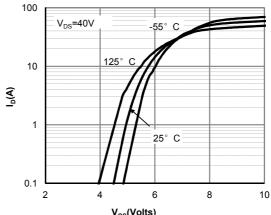
G. L=60mH,  $I_{AS}$ =4.5A,  $V_{DD}$ =150V,  $R_{G}$ =25 $\Omega$ , Starting  $T_{J}$ =25 $^{\circ}$  C



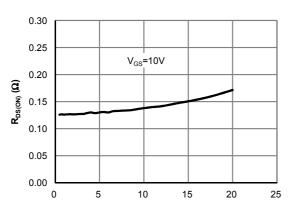
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 $V_{\text{DS}}$  (Volts) Fig 1: On-Region Characteristics



V<sub>GS</sub>(Volts) Figure 2: Transfer Characteristics



 ${
m I_D}\left({
m A}\right)$  Figure 3: On-Resistance vs. Drain Current and Gate Voltage

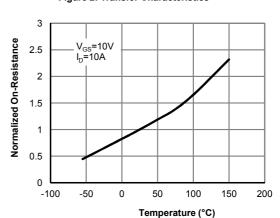
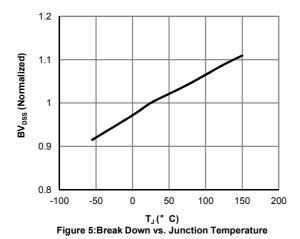
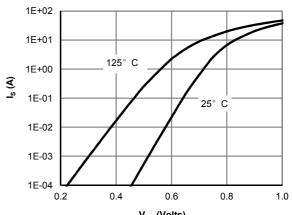


Figure 4: On-Resistance vs. Junction Temperature

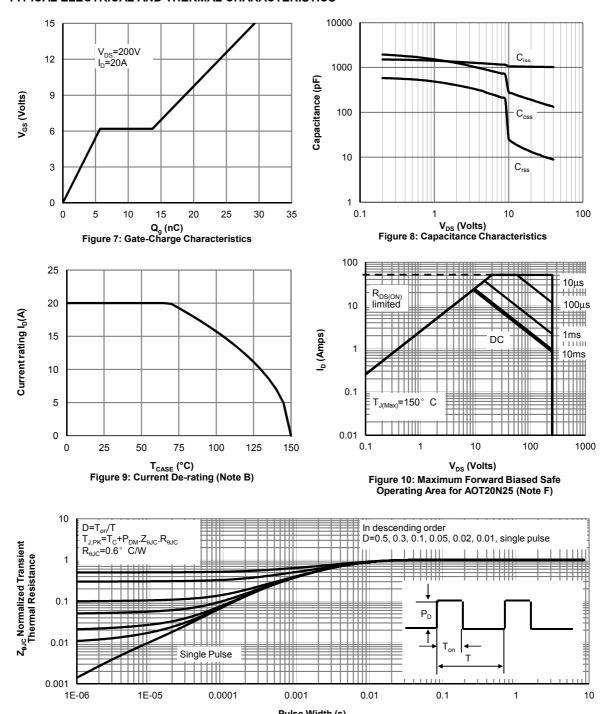




V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



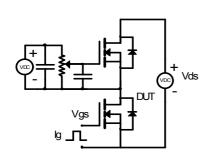
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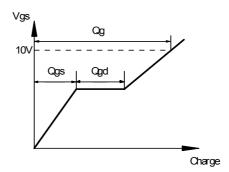


Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance for AOT20N25 (Note F)

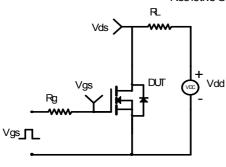


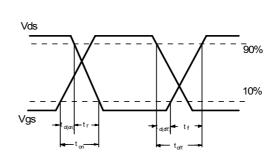
### Gate Charge Test Circuit & Waveform



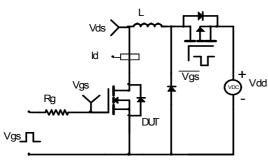


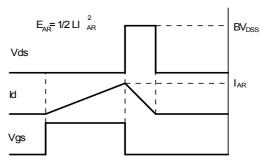
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

